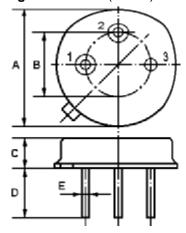


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The ACTR930/930.5/TO39 is a true one-port, surface-acoustic-wave (SAW) resonator in a low-profile metal TO-39 case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at 930.500 MHz.

## 1.Package Dimension (TO-39)

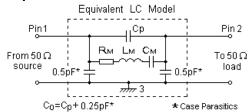


#### 2.

Pin	Configuration			
1	Input / Output			
2	Output / Input			
3	Case Ground			

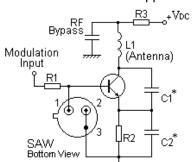
Dimension	Data (unit: mm)			
А	9.30±0.20			
В	5.08±0.10			
С	3.40±0.20			
D	3±0.20/5±0.20			
Е	0.45±0.20			

## 3. Equivalent LC Model and Test Circuit

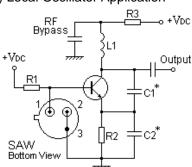


## **4.Typical Application Circuits**

1) Low-Power Transmitter Application



#### 2) Local Oscillator Application



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In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

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For quotations or further information please contact us at:

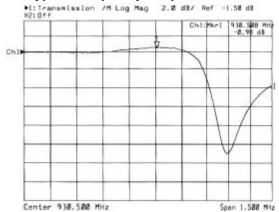
3 The Business Centre, Molly Millars Lane, Wokingham, Berks, RG41 2EY, UK



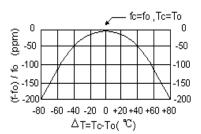
Tel: +44 118 979 1238 Fax: +44 118 979 1283

Email: info@actcrystals.com

## 5. Typical Frequency Response



## **6.Temperature Characteristics**



The curve shown above accounts for resonator contribution only and does not include oscillator temperature characteristics.

## 7.Performance

# 7-1.Maximum Ratings

Rating	Value	Units	
CW RF Power Dissipation	0	dBm	
DC Voltage Between Any Two Pins	±30V	VDC	
Case Temperature	-40 to +85	°C	

# 7-2. Electronic Characteristics

7 2.Dicetronic Characteristics										
	Characteristic	Sym	Minimum	Typical	Maximum	Units				
Centre Frequency (+25 °C)	Absolute Frequency	f <sub>C</sub>	930.350		930.650	MHz				
	Tolerance from 930.500MHz	$\Delta f_{C}$		±150		kHz				
Insertion Loss		IL		1.3	1.8	dB				
Quality Factor	Unloaded Q	Q <sub>U</sub>		11,600						
	50 Ω Loaded Q	$Q_L$		1,600						
Temperature Stability	Turnover Temperature	T <sub>0</sub>	25		55	°C				
	Turnover Frequency	f <sub>0</sub>		f <sub>C</sub>		kHz				
	Frequency Temperature Coefficient	FTC		0.032		ppm/°C <sup>2</sup>				
Frequency Aging	Absolute Value during the First Year	f <sub>A</sub>		≤10		ppm/yr				
DC Insulation Resis	DC Insulation Resistance Between Any Two Pins		1.0			МΩ				
RF Equivalent RLC Model	Motional Resistance	R <sub>M</sub>		16	23	Ω				
	Motional Inductance	L <sub>M</sub>		31.7616		μН				
	Motional Capacitance	См		0.9220		fF				
	Pin 1 to Pin 2 Static Capacitance	C <sub>0</sub>	2.35	2.65	2.95	pF				

# i CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!

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1. The centre frequency,  $f_C$ , is measured at the minimum IL point with the resonator in the 50  $\Omega$  test system. 2. Unless noted otherwise, case temperature  $T_C = +25^{\circ}C \pm 2^{\circ}C$ .

- 3. Frequency aging is the change in fc with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- Turnover temperature, T<sub>0</sub>, is the temperature of maximum (or turnover) frequency, f<sub>0</sub>. The nominal frequency at any case temperature,  $T_C$ , may be calculated from:  $f = f_0 [1 - FTC (T_0 - T_C)^2]$ .
- 5. This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C<sub>0</sub> is the measured static (non-motional) capacitance between Pin1 and Pin2. The measurement includes case parasitic capacitance.
- 6. Derived mathematically from one or more of the following directly measured parameters: f c, IL, 3 dB bandwidth, f<sub>C</sub> versus T<sub>C</sub>, and C<sub>0</sub>.
- 7. The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- 8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- 9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.

In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

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Issue: 1 C1